

**Notice of References Cited**

Application/Control No.

10/004,733

Applicant(s)/Patent Under  
Reexamination  
KURTH ET AL.

Examiner

Erma C. Cameron

Art Unit

1762

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	V	Colvin et al, UTECH Asia, paper 26, 1999
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.